



N-Channel NexFET™ Power MOSFET

FEATURES

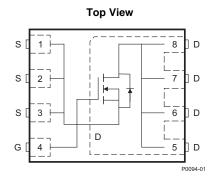
- Ultralow Q_q and Q_{qd}
- Low Thermal Resistance
- Avalanche Rated
- SON 5-mm × 6-mm Plastic Package

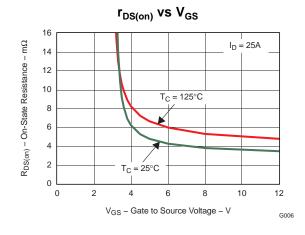
APPLICATIONS

- Point-of-Load Synchronous Buck in Networking, Telecom and Computing Systems
- Optimized for Control FET Applications

DESCRIPTION

The NexFET™ power MOSFET has been designed to minimize losses in power conversion applications.





PRODUCT SUMMARY

V_{DS}	Drain-to-source voltage	25	V	
Q_g	Gate charge, total (4.5 V) 6.7			
Q_{gd}	Gate charge, gate-to-drain 1.9			
_	Drain-to-source on-resistance	V _{GS} = 4.5 V	5.4	mΩ
r _{DS(on)}	Diam-to-source on-resistance	V _{GS} = 10 V	3.6	mΩ
V _{GS(th)}	Threshold voltage	1.8		V

ORDERING INFORMATION

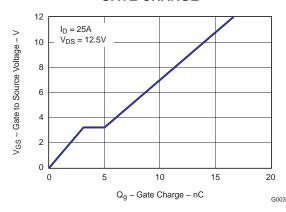
Device	Package	Media	Qty	Ship
CSD16408Q5	SON 5-mm × 6-mm plastic package	13-inch (33-cm) reel	2500	Tape and reel

ABSOLUTE MAXIMUM RATINGS

T _A = 2	5°C unless otherwise stated	VALUE	UNIT
V_{DS}	Drain-to-source voltage	25	V
V_{GS}	Gate-to-source voltage	-12 to 16	V
	Continuous drain current, T _C = 25°C	113	Α
I _D	Continuous drain current ⁽¹⁾	22	Α
I_{DM}	Pulsed drain current, T _A = 25°C ⁽²⁾	141	Α
P_D	Power dissipation ⁽¹⁾	3.1	W
T_J , T_{STG}	Operating junction and storage temperature range	-55 to 150	ů
E _{AS}	Avalanche energy, single-pulse I_D = 23 A, L = 0.1 mH, R_G = 25 Ω	126	mJ

- (1) Typical $R_{\theta JA}$ = 41°C/W on 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu pad on a 0.06-inch (1.52-mm) thick FR4 PCB.
- (2) Pulse duration \leq 300 μ s, duty cycle \leq 2%

GATE CHARGE



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Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



ELECTRICAL CHARACTERISTICS

 $T_{A} = 25^{\circ}C$ unless otherwise stated

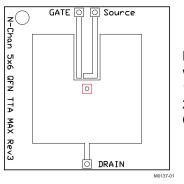
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Static C	haracteristics				·	
BV _{DSS}	Drain-to-source voltage	V _{GS} = 0 V, I _D = 250 μA	25			V
I _{DSS}	Drain-to-source leakage	V _{GS} = 0 V, V _{DS} = 20 V			1	μА
I _{GSS}	Gate-to-source leakage	$V_{DS} = 0 \text{ V}, V_{GS} = -12 \text{ V to } 16 \text{ V}$			100	nA
$V_{GS(th)}$	Gate-to-source threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.4	1.8	2.1	V
-	Drain-to-source on-resistance	$V_{GS} = 4.5 \text{ V}, I_D = 25 \text{ A}$		5.4	6.8	mΩ
r _{DS(on)}	Drain-to-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 25 \text{ A}$		3.6	4.5	mΩ
g _{fs} Transconductance		$V_{DS} = 15 \text{ V}, I_D = 25 \text{ A}$		60		S
Dynamic	c Characteristics					
C _{ISS}	Input capacitance			990	1300	pF
Coss	Output capacitance	V _{GS} = 0 V, V _{DS} = 12.5 V , f = 1 MHz		760	1000	pF
C _{RSS}	Reverse transfer capacitance			75	100	pF
R _g	Series gate resistance			0.8	1.6	Ω
Qg	Gate charge total (4.5 V)			6.7	8.9	nC
Q_{gd}	Gate charge, gate-to-drain	V 42.5 V 1 25.A		1.9		nC
Q _{gs}	Gate charge, gate-to-source	$V_{DS} = 12.5 \text{ V}, I_D = 25 \text{ A}$		3.1		nC
Q _{g(th)}	Gate charge at Vth			1.8		nC
Q _{OSS}	Output charge	$V_{DS} = 13 \text{ V}, V_{GS} = 0 \text{ V}$		15.7		nC
t _{d(on)}	Turnon delay time			11.3		ns
t _r	Rise time	V _{DS} = 12.5 V, V _{GS} = 4.5 V,		25		ns
t _{d(off)}	Turnoff delay time	$I_D = 20 \text{ A}, R_G = 2 \Omega$		11		ns
t _f	Fall time			10.8		ns
Diode C	haracteristics	<u> </u>				
V_{SD}	Diode forward voltage	I _S = 25 A, V _{GS} = 0 V		0.8	1	V
Q _{rr}	Reverse recovery charge	$V_{DD} = 13 \text{ V}, I_F = 2 \text{ 5A}, \text{ di/dt} = 300 \text{ A/}\mu\text{s}$		17		nC
t _{rr}	Reverse recovery time	V _{DD} = 13 V, I _F = 25 A, di/dt = 300 A/μs		21		ns

THERMAL CHARACTERISTICS

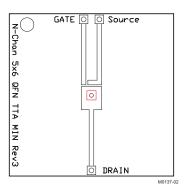
· A - 20 ·	5 direct direct whole stated				
	PARAMETER	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Thermal Resistance Junction to Case ⁽¹⁾			1.9	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient ⁽¹⁾ (2)			51	°C/W

 ⁽¹⁾ R_{θJC} is determined with the device mounted on a 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu pad on a 1.5-inch x 1.5-inch (3.81-cm x 3.81-cm), 0.06-inch (1.52-mm) thick FR4 PCB. R_{θJC} is specified by design, whereas R_{θJA} is determined by the user's board design.
(2) Device mounted on FR4 material with 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu.





Max $R_{\theta JA} = 51^{o}C/W$ when mounted on 1 inch² (6.45 cm²) of 2-oz. (0.071-mm thick) Cu.



Max $R_{\theta JA} = 125^{o} C/W$ when mounted on minimum pad area of 2-oz. (0.071-mm thick) Cu.

TYPICAL MOSFET CHARACTERISTICS

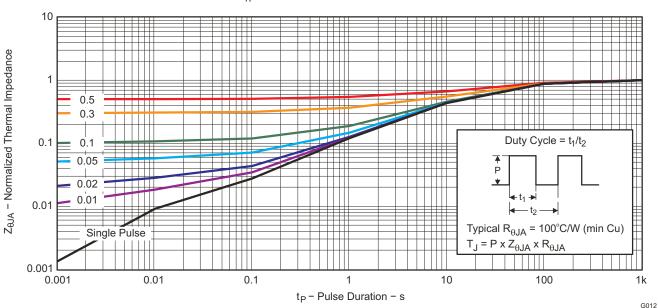


Figure 1. Transient Thermal Impedance



TYPICAL MOSFET CHARACTERISTICS (continued)

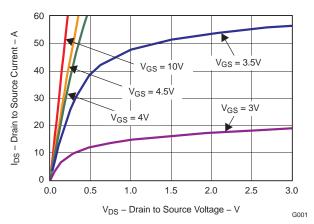


Figure 2. Saturation Characteristics

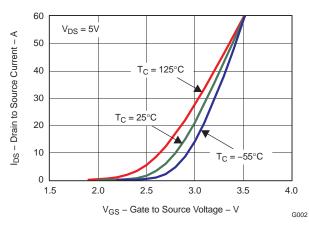


Figure 3. Transfer Characteristics

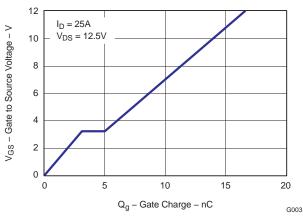


Figure 4. Gate Charge

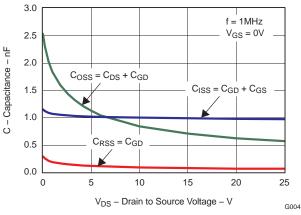


Figure 5. Capacitance

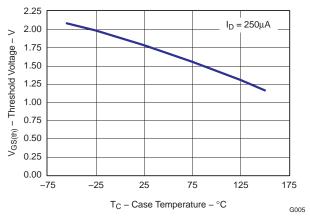


Figure 6. Threshold Voltage vs. Temperature

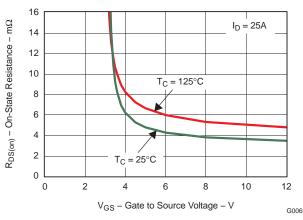


Figure 7. On-State Resistance vs. Gate-to-Source Voltage



TYPICAL MOSFET CHARACTERISTICS (continued)

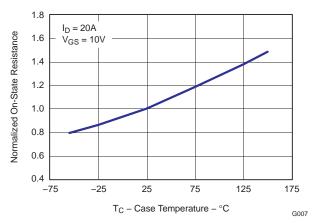


Figure 8. Normalized On-State Resistance vs. Temperature

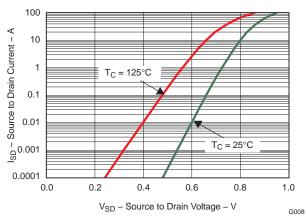


Figure 9. Typical Diode Forward Voltage

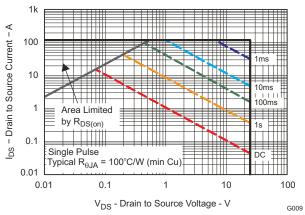


Figure 10. Maximum Safe Operating Area

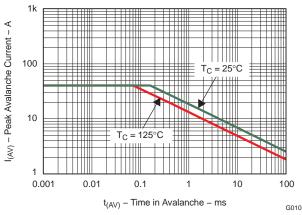


Figure 11. Single-Pulse Unclamped Inductive Switching

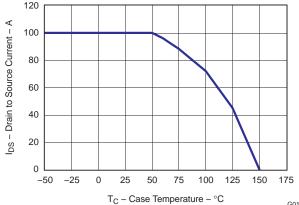
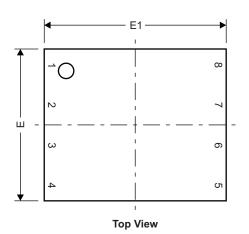


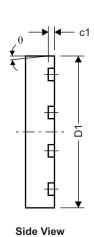
Figure 12. Maximum Drain Current vs. Temperature

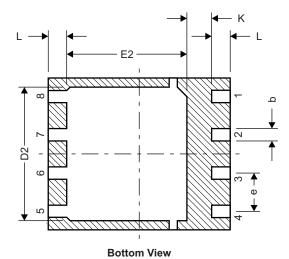


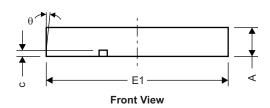
MECHANICAL DATA

Q5 Package Dimensions





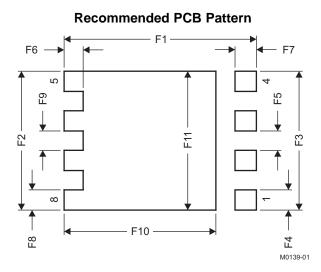




M0140-01

DIM	MILLIM	ETERS	INC	HES
DIIVI	MIN	MAX	MIN	MAX
Α	0.950	1.050	0.037	0.039
b	0.360	0.460	0.014	0.018
С	0.150	0.250	0.006	0.010
c1	0.150	0.250	0.006	0.010
D1	4.900	5.100 0.1	0.193	0.201
D2	4.320	4.520	0.170	0.178
E	4.900	5.100	0.193	0.201
E1	5.900	6.100	0.232	0.240
E2	3.920 4.12 0		0.154	0.162
е	1.27	typ	0.0)50
L	0.510	0.710	0.020	0.028
θ	0.00	_	_	_

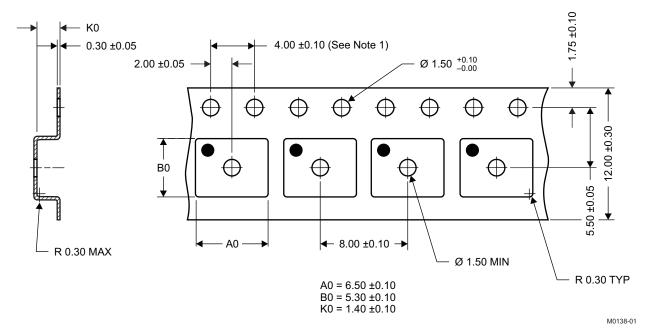




DIM	MILLIM	IETERS	INCHES			
DIN	MIN	MAX	MIN	MAX		
F1	6.205	6.305	0.244	0.248		
F2	4.46	4.56	0.176	0.18		
F3	4.46	4.56	0.176	0.18		
F4	0.65	0.7	0.026	0.028		
F5	0.62	0.67	0.024	0.026		
F6	0.63	0.68	0.025	0.027		
F7	0.7	0.8	0.028	0.031		
F8	0.65	0.7	0.026	0.028		
F9	0.62	0.67	0.024	0.026		
F10	4.9	5	0.193	0.197		
F11	4.46	4.56	0.176	0.18		

For recommended circuit layout for PCB designs, see application note *Reducing Ringing Through PCB Layout Techniques* (SLPA005).

Q5 Tape and Reel Information



Notes:

- 1. 10-sprocket hole-pitch cumulative tolerance ±0.2
- 2. Camber not to exceed 1 mm in 100 mm, noncumulative over 250 mm
- 3. Material: black static-dissipative polystyrene
- 4. All dimensions are in mm, unless otherwise specified.
- 5. A0 and B0 measured on a plane 0.3 mm above the bottom of the pocket
- 6. MSL1 260°C (IR and convection) PbF reflow compatible



REVISION HISTORY

C	changes from Revision Original (October 2009) to Revision A	Page
•	Deleted environmental bullets from features list	1
•	Deleted package marking section from end of data sheet	7



PACKAGE OPTION ADDENDUM

7-Jan-2016

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
CSD16408Q5	ACTIVE	VSON-CLIP	DQH	8	•	Pb-Free (RoHS Exempt)	CU SN	Level-1-260C-UNLIM	-55 to 150	CSD16408	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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